

## Trench gate field-stop IGBT, M series 650 V, 20 A low loss

Datasheet - production data

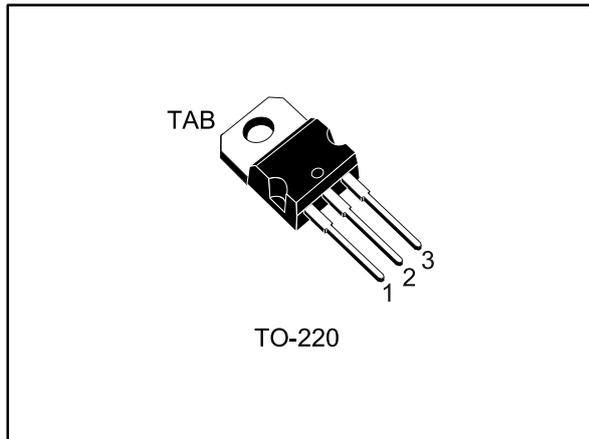
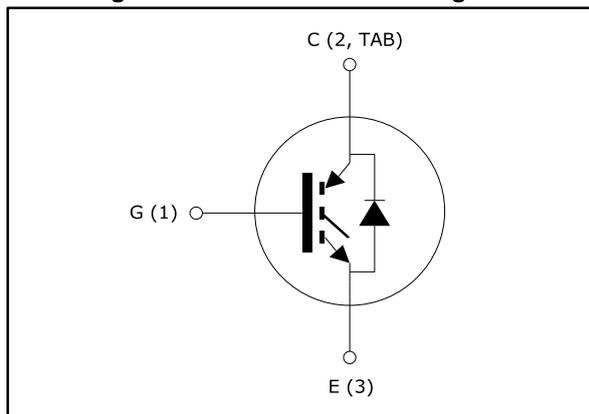


Figure 1: Internal schematic diagram



### Features

- High short-circuit withstand time
- $V_{CE(sat)} = 1.55 \text{ V (typ.) @ } I_C = 20 \text{ A}$
- Tight parameters distribution
- Safer paralleling
- Low thermal resistance
- Soft and very fast recovery antiparallel diode

### Applications

- Motor control
- UPS
- PFC

### Description

This device is an IGBT developed using an advanced proprietary trench gate field-stop structure. The device is part of the M series IGBTs, which represent an optimal balance between inverter system performance and efficiency where low-loss and short-circuit functionality are essential. Furthermore, the positive  $V_{CE(sat)}$  temperature coefficient and tight parameter distribution result in safer paralleling operation.

Table 1: Device summary

| Order code   | Marking   | Package | Packing |
|--------------|-----------|---------|---------|
| STGP20M65DF2 | G20M65DF2 | TO-220  | Tube    |

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## Contents

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# 1 Electrical ratings

**Table 2: Absolute maximum ratings**

| Symbol         | Parameter   | Value       | Unit |
|----------------|---|-------------|------|
| $V_{CES}$      | Collector-emitter voltage ( $V_{GE} = 0$ )            | 650         | V    |
| $I_C^{(1)}$    | Continuous collector current at $T_C = 25\text{ °C}$  | 40          | A    |
| $I_C^{(1)}$    | Continuous collector current at $T_C = 100\text{ °C}$ | 20          | A    |
| $I_{CP}^{(2)}$ | Pulsed collector current                              | 80          | A    |
| $V_{GE}$       | Gate-emitter voltage                                  | $\pm 20$    | V    |
| $I_F^{(1)}$    | Continuous forward current at $T_C = 25\text{ °C}$    | 40          | A    |
| $I_F^{(1)}$    | Continuous forward current at $T_C = 100\text{ °C}$   | 20          | A    |
| $I_{FP}^{(2)}$ | Pulsed forward current                                | 80          | A    |
| $P_{TOT}$      | Total dissipation at $T_C = 25\text{ °C}$             | 166         | W    |
| $T_{STG}$      | Storage temperature range                             | - 55 to 150 | °C   |
| $T_J$          | Operating junction temperature range                  | - 55 to 175 | °C   |

**Notes:**

<sup>(1)</sup>Limited by maximum junction temperature.

<sup>(2)</sup>Pulse width limited by maximum junction temperature.

**Table 3: Thermal data**

| Symbol     | Parameter                              | Value | Unit |
|------------|--|-------|------|
| $R_{thJC}$ | Thermal resistance junction-case IGBT  | 0.9   | °C/W |
| $R_{thJC}$ | Thermal resistance junction-case diode | 2.08  | °C/W |
| $R_{thJA}$ | Thermal resistance junction-ambient    | 62.5  | °C/W |

## 2 Electrical characteristics

$T_C = 25\text{ °C}$  unless otherwise specified

**Table 4: Static characteristics**

| Symbol        | Parameter                            | Test conditions   | Min. | Typ. | Max. | Unit          |
|---------------|--------------------------------------|---|------|------|------|---------------|
| $V_{(BR)CES}$ | Collector-emitter breakdown voltage  | $V_{GE} = 0\text{ V}$ , $I_C = 250\text{ }\mu\text{A}$                  | 650  |      |      | V             |
| $V_{CE(sat)}$ | Collector-emitter saturation voltage | $V_{GE} = 15\text{ V}$ , $I_C = 20\text{ A}$                            |      | 1.55 | 2.0  | V             |
|               |                                      | $V_{GE} = 15\text{ V}$ , $I_C = 20\text{ A}$ ,<br>$T_J = 125\text{ °C}$ |      | 1.95 |      |               |
|               |                                      | $V_{GE} = 15\text{ V}$ , $I_C = 20\text{ A}$ ,<br>$T_J = 175\text{ °C}$ |      | 2.1  |      |               |
| $V_F$         | Forward on-voltage                   | $I_F = 20\text{ A}$   |      | 1.85 |      | V             |
|               |                                      | $I_F = 20\text{ A}$ , $T_J = 125\text{ °C}$                             |      | 1.65 |      |               |
|               |                                      | $I_F = 20\text{ A}$ , $T_J = 175\text{ °C}$                             |      | 1.55 |      |               |
| $V_{GE(th)}$  | Gate threshold voltage               | $V_{CE} = V_{GE}$ , $I_C = 500\text{ }\mu\text{A}$                      | 5    | 6    | 7    | V             |
| $I_{CES}$     | Collector cut-off current            | $V_{GE} = 0\text{ V}$ , $V_{CE} = 650\text{ V}$                         |      |      | 25   | $\mu\text{A}$ |
| $I_{GES}$     | Gate-emitter leakage current         | $V_{CE} = 0\text{ V}$ , $V_{GE} = \pm 20\text{ V}$                      |      |      | 250  | $\mu\text{A}$ |

**Table 5: Dynamic characteristics**

| Symbol    | Parameter                    | Test conditions  | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|--|------|------|------|------|
| $C_{ies}$ | Input capacitance            | $V_{CE} = 25\text{ V}$ , $f = 1\text{ MHz}$ , $V_{GE} = 0\text{ V}$  | -    | 1688 | -    | pF   |
| $C_{oes}$ | Output capacitance           |  | -    | 95   | -    |      |
| $C_{res}$ | Reverse transfer capacitance |  | -    | 35   | -    |      |
| $Q_g$     | Total gate charge            | $V_{CC} = 520\text{ V}$ , $I_C = 20\text{ A}$ , $V_{GE} = 15\text{ V}$<br>(see <a href="#">Figure 30: "Gate charge test circuit"</a> ) | -    | 63   | -    | nC   |
| $Q_{ge}$  | Gate-emitter charge          |  | -    | 15   | -    |      |
| $Q_{gc}$  | Gate-collector charge        |  | -    | 26   | -    |      |

Table 6: IGBT switching characteristics (inductive load)

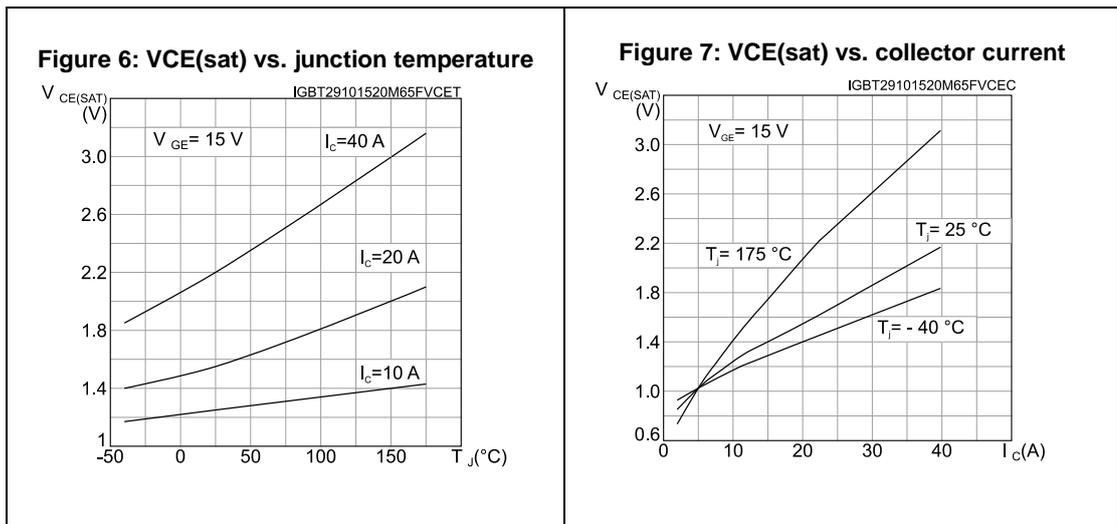
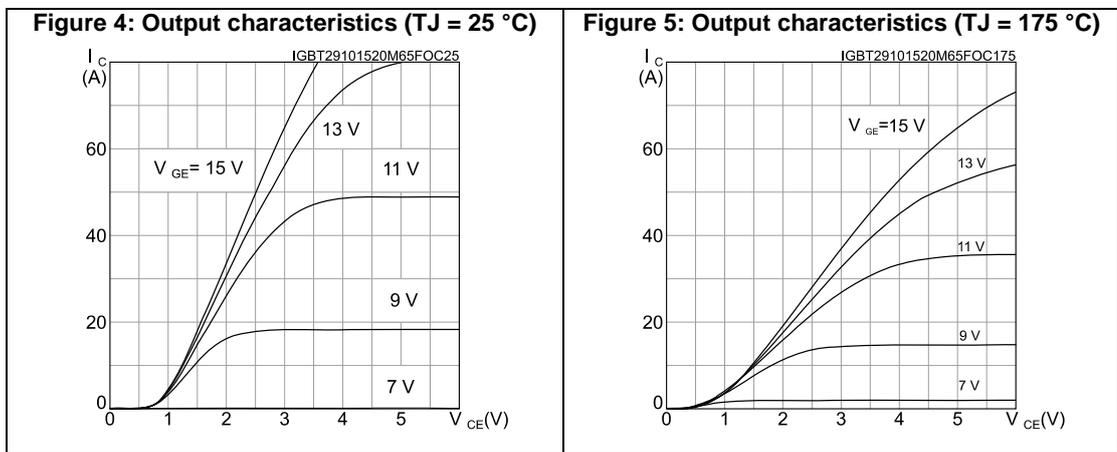
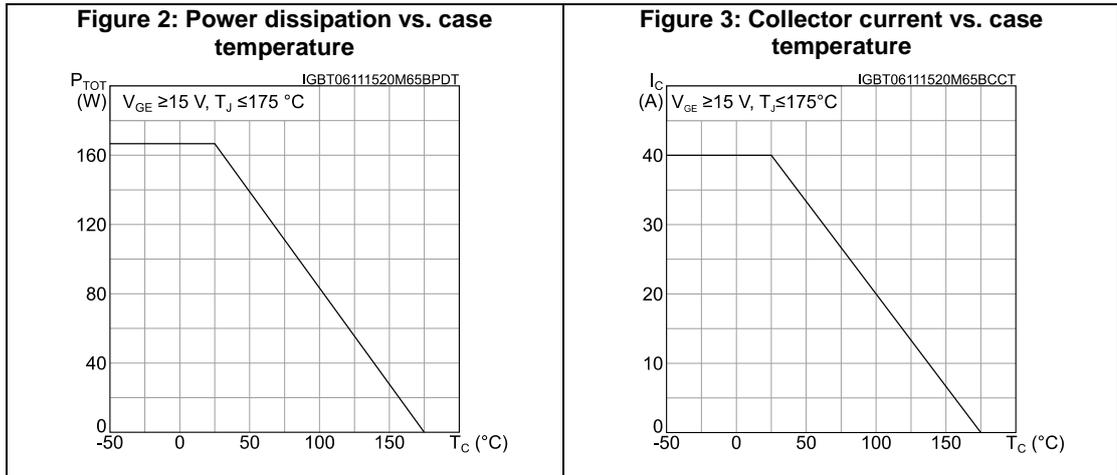
| Symbol         | Parameter                    | Test conditions   | Min. | Typ. | Max. | Unit       |
|----------------|------------------------------|---|------|------|------|------------|
| $t_{d(on)}$    | Turn-on delay time           | $V_{CE} = 400\text{ V}$ , $I_C = 20\text{ A}$ , $V_{GE} = 15\text{ V}$ ,<br>$R_G = 12\ \Omega$<br>(see <a href="#">Figure 29: "Test circuit for inductive load switching"</a> )                                     |      | 26   | -    | ns         |
| $t_r$          | Current rise time            |   |      | 10.8 | -    | ns         |
| $(di/dt)_{on}$ | Turn-on current slope        |   |      | 1409 | -    | A/ $\mu$ s |
| $t_{d(off)}$   | Turn-off-delay time          |   |      | 108  | -    | ns         |
| $t_f$          | Current fall time            |   |      | 65   | -    | ns         |
| $E_{on(1)}$    | Turn-on switching energy     |   |      | 0.14 | -    | mJ         |
| $E_{off(2)}$   | Turn-off switching energy    |   |      | 0.56 | -    | mJ         |
| $E_{ts}$       | Total switching energy       |   | 0.7  | -    | mJ   |            |
| $t_{d(on)}$    | Turn-on delay time           | $V_{CE} = 400\text{ V}$ , $I_C = 20\text{ A}$ , $V_{GE} = 15\text{ V}$ ,<br>$R_G = 12\ \Omega$ , $T_J = 175\text{ }^\circ\text{C}$<br>(see <a href="#">Figure 29: "Test circuit for inductive load switching"</a> ) |      | 28.4 | -    | ns         |
| $t_r$          | Current rise time            |   |      | 11.2 | -    | ns         |
| $(di/dt)_{on}$ | Turn-on current slope        |   |      | 1393 | -    | A/ $\mu$ s |
| $t_{d(off)}$   | Turn-off-delay time          |   |      | 107  | -    | ns         |
| $t_f$          | Current fall time            |   |      | 145  | -    | ns         |
| $E_{on(1)}$    | Turn-on switching energy     |   |      | 0.3  | -    | mJ         |
| $E_{off(2)}$   | Turn-off switching energy    |   |      | 0.85 | -    | mJ         |
| $E_{ts}$       | Total switching energy       |   | 1.15 | -    | mJ   |            |
| $t_{sc}$       | Short-circuit withstand time | $V_{CC} = 400\text{ V}$ , $V_{GE} = 13\text{ V}$ ,<br>$T_{Jstart} = 150\text{ }^\circ\text{C}$  | 10   |      | -    | $\mu$ s    |
|                |                              | $V_{CC} = 400\text{ V}$ , $V_{GE} = 15\text{ V}$ ,<br>$T_{Jstart} = 150\text{ }^\circ\text{C}$  | 6    |      | -    |            |

**Notes:**<sup>(1)</sup>Including the reverse recovery of the diode.<sup>(2)</sup>Including the tail of the collector current.

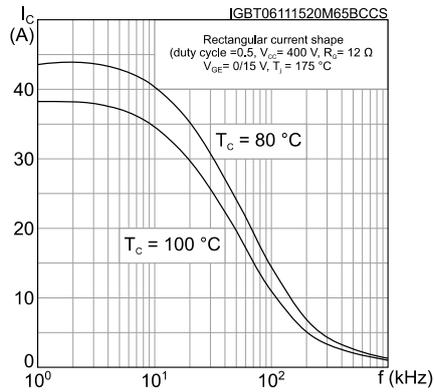
Table 7: Diode switching characteristics (inductive load)

| Symbol       | Parameter  | Test conditions  | Min. | Typ. | Max. | Unit             |
|--------------|--|--|------|------|------|------------------|
| $t_{rr}$     | Reverse recovery time                                      | $I_F = 20\text{ A}$ , $V_R = 400\text{ V}$ , $V_{GE} = 15\text{ V}$<br>(see <a href="#">Figure 29: "Test circuit for inductive load switching"</a> )<br>$di/dt = 1000\text{ A}/\mu\text{s}$                                      | -    | 166  |      | ns               |
| $Q_{rr}$     | Reverse recovery charge                                    |  | -    | 690  |      | nC               |
| $I_{rrm}$    | Reverse recovery current                                   |  | -    | 13.2 |      | A                |
| $dl_{rr}/dt$ | Peak rate of fall of reverse recovery current during $t_b$ |  | -    | 769  |      | A/ $\mu\text{s}$ |
| $E_{rr}$     | Reverse recovery energy                                    |  | -    | 81   |      | $\mu\text{J}$    |
| $t_{rr}$     | Reverse recovery time                                      | $I_F = 20\text{ A}$ , $V_R = 400\text{ V}$ , $V_{GE} = 15\text{ V}$<br>$T_J = 175\text{ }^\circ\text{C}$<br>(see <a href="#">Figure 29: "Test circuit for inductive load switching"</a> )<br>$di/dt = 1000\text{ A}/\mu\text{s}$ | -    | 281  |      | ns               |
| $Q_{rr}$     | Reverse recovery charge                                    |  | -    | 2010 |      | nC               |
| $I_{rrm}$    | Reverse recovery current                                   |  | -    | 19.6 |      | A                |
| $dl_{rr}/dt$ | Peak rate of fall of reverse recovery current during $t_b$ |  | -    | 370  |      | A/ $\mu\text{s}$ |
| $E_{rr}$     | Reverse recovery energy                                    |  | -    | 215  |      | $\mu\text{J}$    |

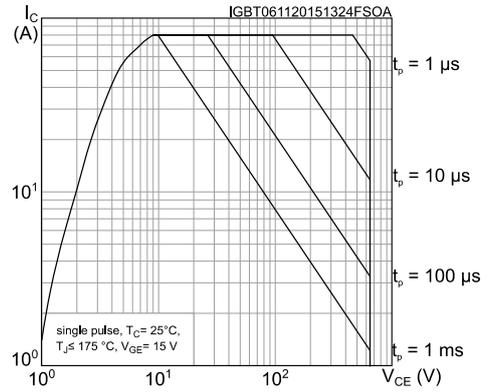
## 2.1 Electrical characteristics (curves)



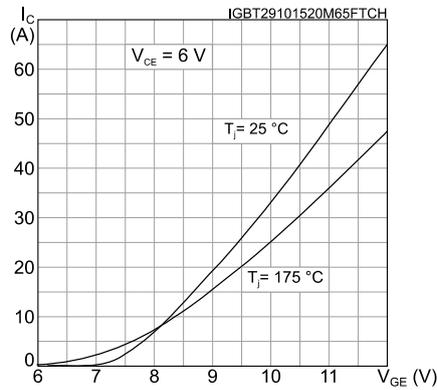
**Figure 8: Collector current vs. switching frequency**



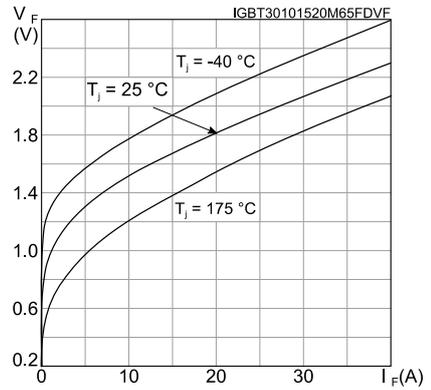
**Figure 9: Forward bias safe operating area**



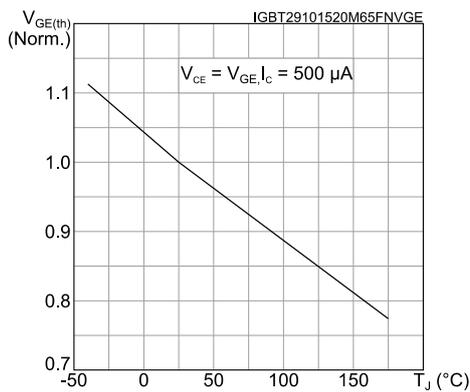
**Figure 10: Transfer characteristics**



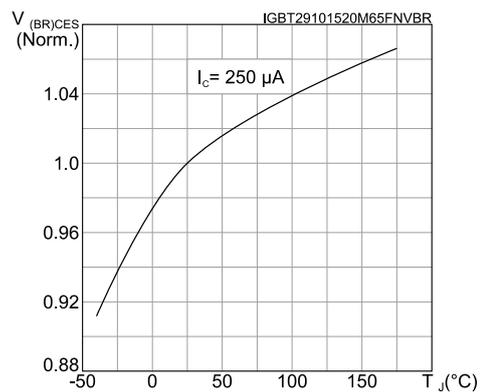
**Figure 11: Diode VF vs. forward current**



**Figure 12: Normalized VGE(th) vs. junction temperature**



**Figure 13: Normalized V(BR)CES vs. junction temperature**



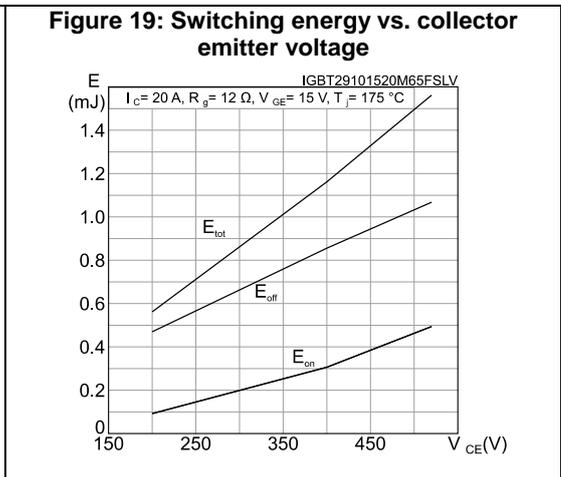
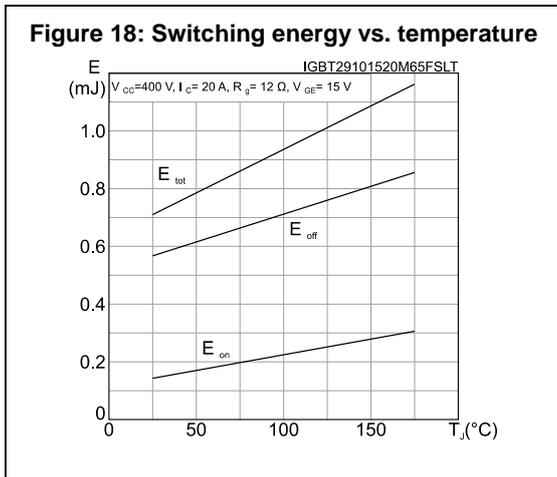
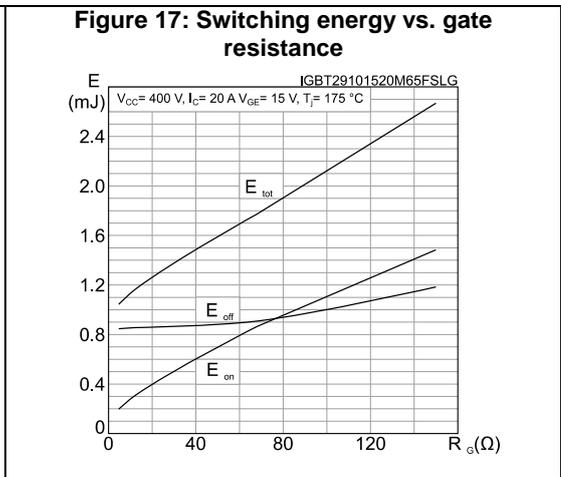
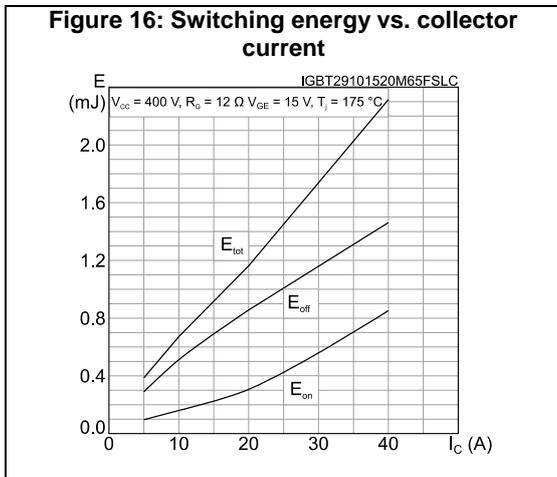
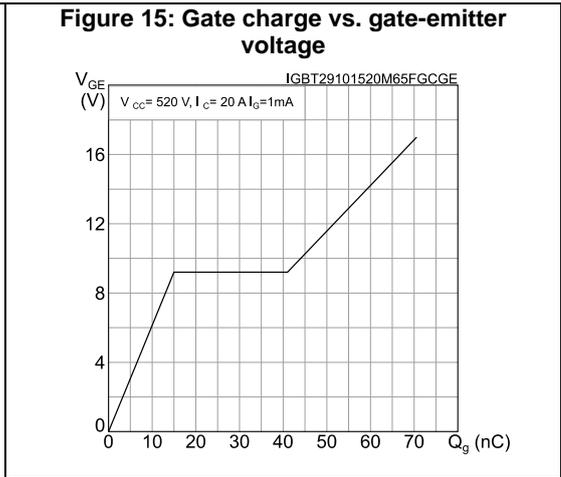
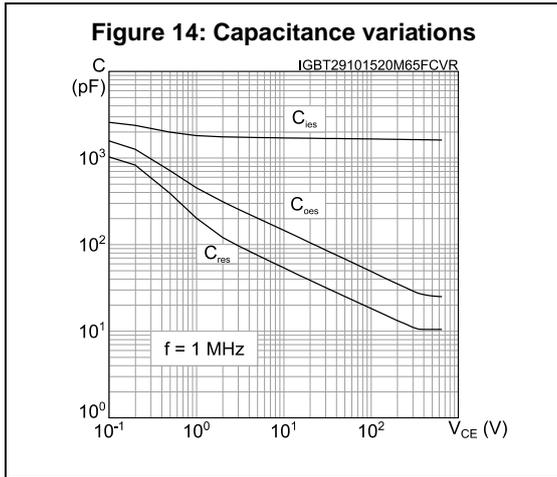


Figure 20: Short-circuit time and current vs. V<sub>GE</sub>

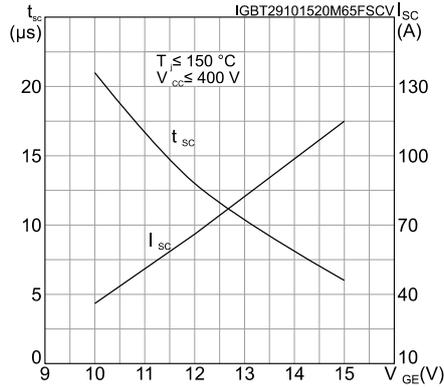


Figure 21: Switching times vs. collector current

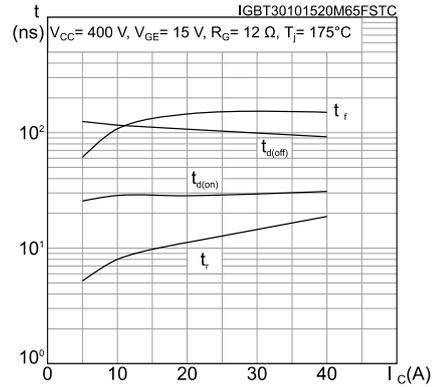


Figure 22: Switching times vs. gate resistance

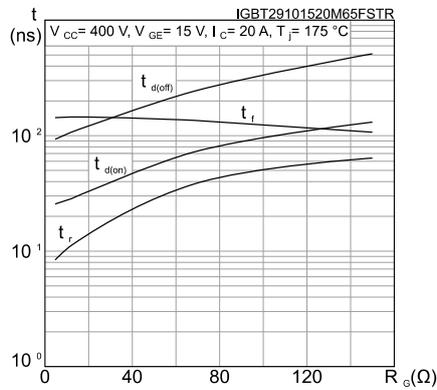


Figure 23: Reverse recovery current vs. diode current slope

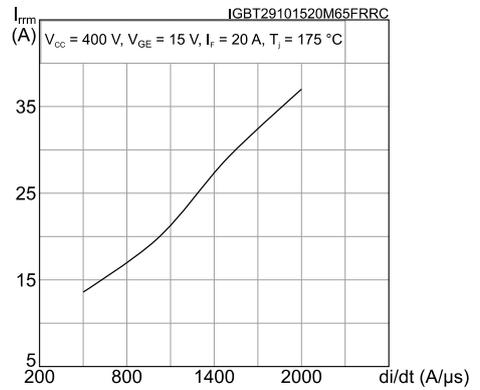


Figure 24: Reverse recovery time vs. diode current slope



Figure 25: Reverse recovery charge vs. diode current slope

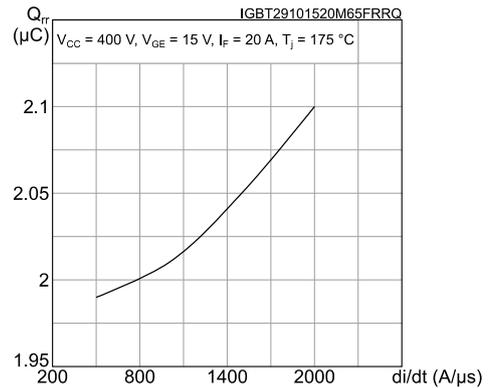


Figure 26: Reverse recovery energy vs. diode current slope

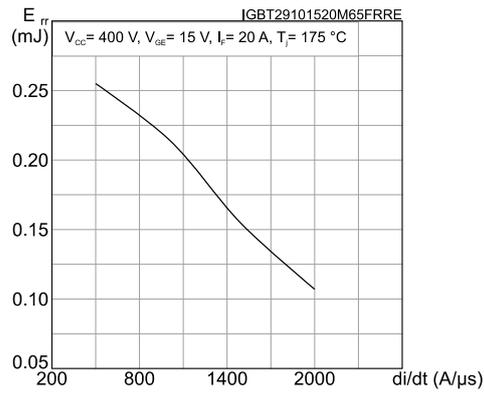


Figure 27: Thermal impedance for IGBT

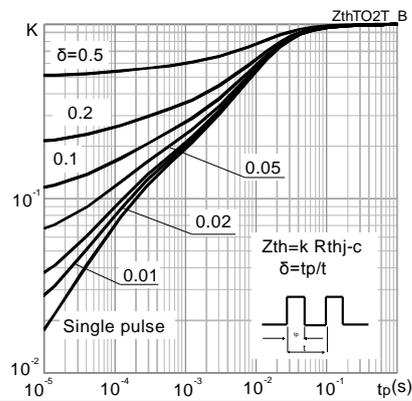
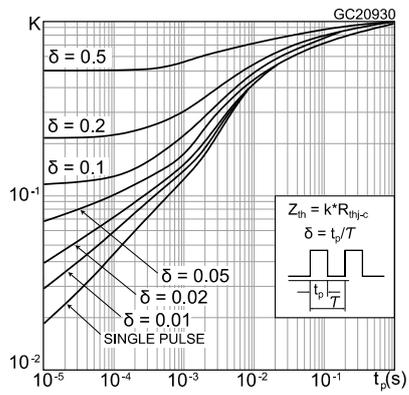


Figure 28: Thermal impedance for diode



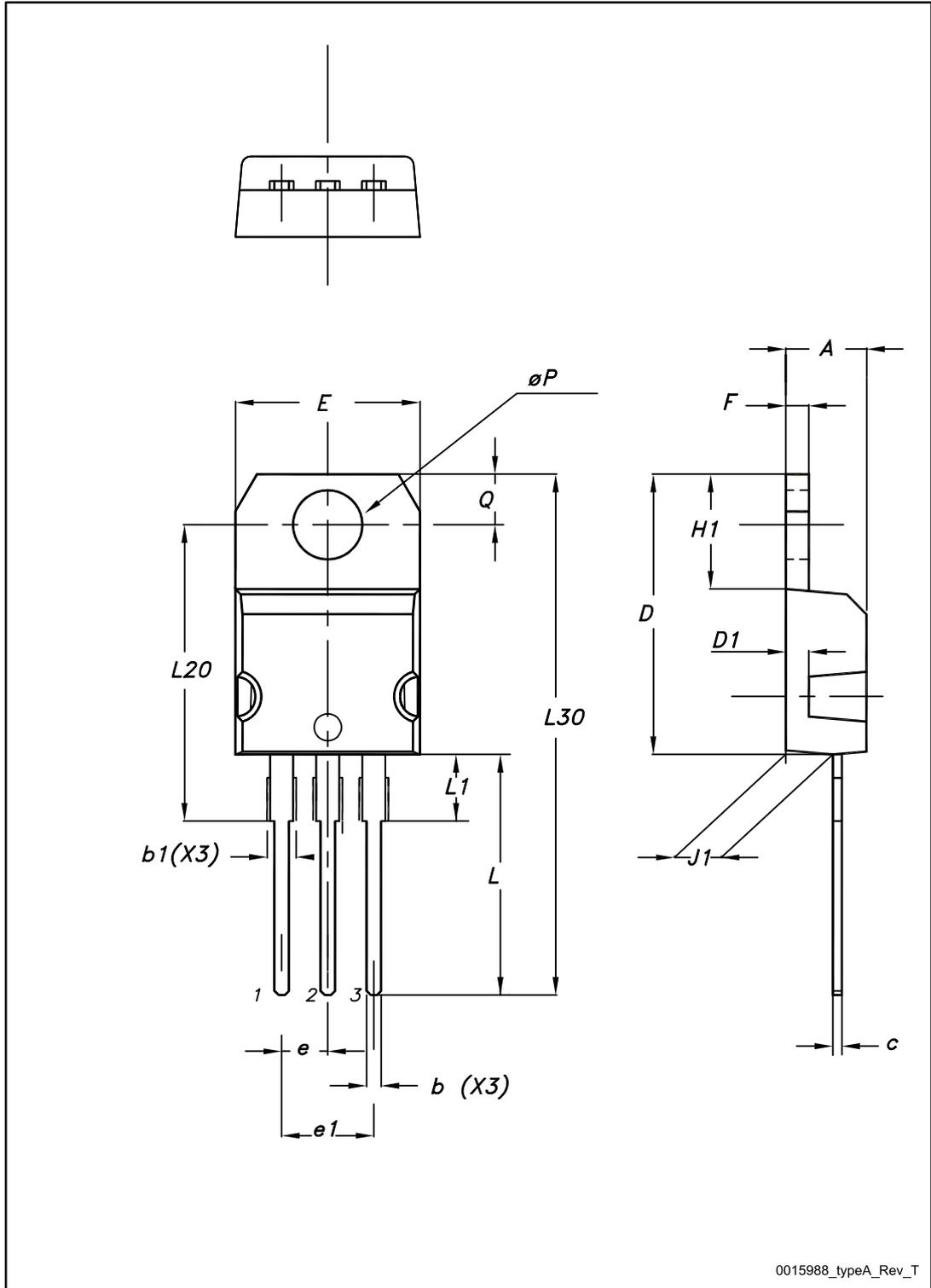


## 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

### 4.1 TO-220 type A package information

Figure 33: TO-220 type A package outline



0015988\_typeA\_Rev\_T

Table 8: TO-220 type A mechanical data

| Dim. | mm    |       |       |
|------|-------|-------|-------|
|      | Min.  | Typ.  | Max.  |
| A    | 4.40  |       | 4.60  |
| b    | 0.61  |       | 0.88  |
| b1   | 1.14  |       | 1.70  |
| c    | 0.48  |       | 0.70  |
| D    | 15.25 |       | 15.75 |
| D1   |       | 1.27  |       |
| E    | 10    |       | 10.40 |
| e    | 2.40  |       | 2.70  |
| e1   | 4.95  |       | 5.15  |
| F    | 1.23  |       | 1.32  |
| H1   | 6.20  |       | 6.60  |
| J1   | 2.40  |       | 2.72  |
| L    | 13    |       | 14    |
| L1   | 3.50  |       | 3.93  |
| L20  |       | 16.40 |       |
| L30  |       | 28.90 |       |
| øP   | 3.75  |       | 3.85  |
| Q    | 2.65  |       | 2.95  |

## 5 Revision history

Table 9: Document revision history

| Date        | Revision | Changes   |
|-------------|----------|---|
| 11-Nov-2015 | 1        | First release.  |
| 18-Apr-2016 | 2        | Updated <a href="#">Figure 13: "Normalized V(BR)CES vs. junction temperature "</a> .<br>Minor text changes. |

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